



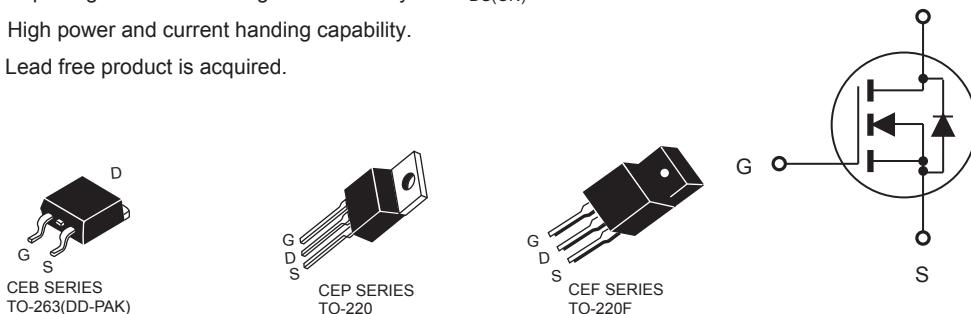
# CEP10N6/CEB10N6 CEF10N6

## N-Channel Enhancement Mode Field Effect Transistor

### FEATURES

| Type    | V <sub>DSS</sub> | R <sub>DS(ON)</sub> | I <sub>D</sub>   | @V <sub>GS</sub> |
|---------|------------------|---------------------|------------------|------------------|
| CEP10N6 | 600V             | 0.75Ω               | 10A              | 10V              |
| CEB10N6 | 600V             | 0.75Ω               | 10A              | 10V              |
| CEF10N6 | 600V             | 0.75Ω               | 10A <sup>d</sup> | 10V              |

- Super high dense cell design for extremely low R<sub>DS(ON)</sub>.
- High power and current handing capability.
- Lead free product is acquired.



### ABSOLUTE MAXIMUM RATINGS T<sub>C</sub> = 25°C unless otherwise noted

| Parameter  | Symbol                         | Limit      |                 | Units |
|--|--------------------------------|------------|-----------------|-------|
|  |                                | TO-220/263 | TO-220F         |       |
| Drain-Source Voltage   | V <sub>DS</sub>                | 600        |                 | V     |
| Gate-Source Voltage  | V <sub>GS</sub>                | ±30        |                 | V     |
| Drain Current-Continuous @ T <sub>C</sub> = 25°C<br>@ T <sub>C</sub> = 100°C | I <sub>D</sub>                 | 10         | 10 <sup>d</sup> | A     |
|  |                                | 6          | 6 <sup>d</sup>  | A     |
| Drain Current-Pulsed <sup>a</sup>  | I <sub>DM</sub> <sup>e</sup>   | 40         | 40 <sup>d</sup> | A     |
| Maximum Power Dissipation @ T <sub>C</sub> = 25°C<br>- Derate above 25°C     | P <sub>D</sub>                 | 166        | 50              | W     |
|  |                                | 1.3        | 0.4             | W/°C  |
| Single Pulsed Avalanche Energy <sup>h</sup>                                  | E <sub>AS</sub>                | 187.5      |                 | mJ    |
| Single Pulsed Avalanche Current <sup>h</sup>                                 | I <sub>AS</sub>                | 5          |                 | A     |
| Operating and Store Temperature Range  | T <sub>J,T<sub>stg</sub></sub> | -55 to 175 |                 | °C    |

### Thermal Characteristics

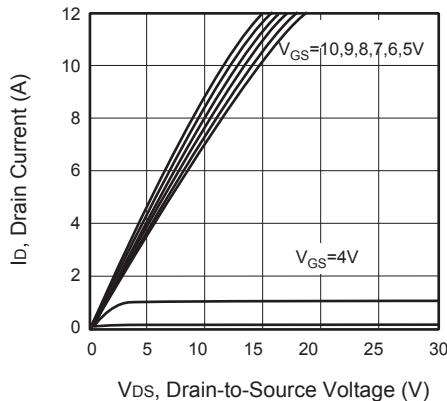
| Parameter                               | Symbol           | Limit |     | Units |
|---|------------------|-------|-----|-------|
| Thermal Resistance, Junction-to-Case    | R <sub>θJC</sub> | 0.75  | 2.5 | °C/W  |
| Thermal Resistance, Junction-to-Ambient | R <sub>θJA</sub> | 62.5  | 65  | °C/W  |



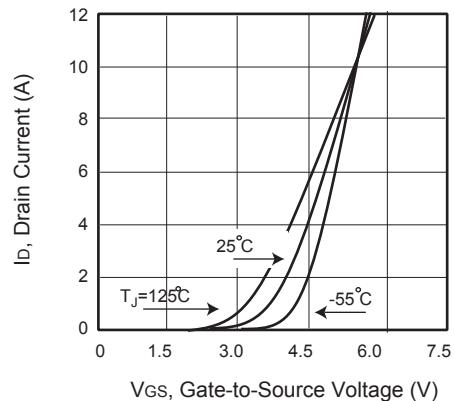
# CEP10N6/CEB10N6 CEF10N6

## Electrical Characteristics $T_C = 25^\circ\text{C}$ unless otherwise noted

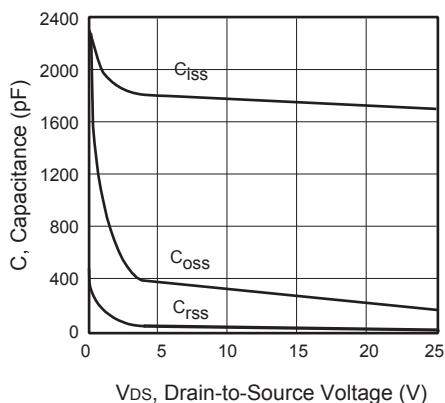
| Parameter   | Symbol                   | Test Condition   | Min | Typ  | Max  | Units         |
|---|--------------------------|--|-----|------|------|---------------|
| <b>Off Characteristics</b>  |                          |  |     |      |      |               |
| Drain-Source Breakdown Voltage  | $\text{BV}_{\text{DSS}}$ | $V_{\text{GS}} = 0\text{V}, I_D = 250\mu\text{A}$  | 600 |      |      | V             |
| Zero Gate Voltage Drain Current   | $I_{\text{DSS}}$         | $V_{\text{DS}} = 600\text{V}, V_{\text{GS}} = 0\text{V}$   |     | 1    |      | $\mu\text{A}$ |
|   |                          | $V_{\text{DS}} = 480\text{V}, T_C = 125^\circ\text{C}$   |     | 10   |      | $\mu\text{A}$ |
| Gate Body Leakage Current, Forward  | $I_{\text{GSSF}}$        | $V_{\text{GS}} = 30\text{V}, V_{\text{DS}} = 0\text{V}$  |     | 100  |      | nA            |
| Gate Body Leakage Current, Reverse  | $I_{\text{GSSR}}$        | $V_{\text{GS}} = -30\text{V}, V_{\text{DS}} = 0\text{V}$   |     | -100 |      | nA            |
| <b>On Characteristics<sup>b</sup></b>   |                          |  |     |      |      |               |
| Gate Threshold Voltage  | $V_{\text{GS(th)}}$      | $V_{\text{GS}} = V_{\text{DS}}, I_D = 250\mu\text{A}$  | 2   |      | 4    | V             |
| Static Drain-Source On-Resistance   | $R_{\text{DS(on)}}$      | $V_{\text{GS}} = 10\text{V}, I_D = 5\text{A}$  |     | 0.65 | 0.75 | $\Omega$      |
| <b>Dynamic Characteristics<sup>c</sup></b>  |                          |  |     |      |      |               |
| Input Capacitance   | $C_{\text{iss}}$         | $V_{\text{DS}} = 25\text{V}, V_{\text{GS}} = 0\text{V}, f = 1.0 \text{ MHz}$                           |     | 1760 |      | pF            |
| Output Capacitance  | $C_{\text{oss}}$         |  |     | 220  |      | pF            |
| Reverse Transfer Capacitance  | $C_{\text{rss}}$         |  |     | 20   |      | pF            |
| <b>Switching Characteristics<sup>c</sup></b>  |                          |  |     |      |      |               |
| Turn-On Delay Time  | $t_{\text{d(on)}}$       | $V_{\text{DD}} = 300\text{V}, I_D = 10\text{A}, V_{\text{GS}} = 10\text{V}, R_{\text{GEN}} = 25\Omega$ |     | 32.5 |      | ns            |
| Turn-On Rise Time   | $t_r$                    |  |     | 61   |      | ns            |
| Turn-Off Delay Time   | $t_{\text{d(off)}}$      |  |     | 150  |      | ns            |
| Turn-Off Fall Time  | $t_f$                    |  |     | 60   |      | ns            |
| Total Gate Charge   | $Q_g$                    | $V_{\text{DS}} = 480\text{V}, I_D = 10\text{A}, V_{\text{GS}} = 10\text{V}$                            |     | 44   |      | nC            |
| Gate-Source Charge  | $Q_{\text{gs}}$          |  |     | 7.7  |      | nC            |
| Gate-Drain Charge   | $Q_{\text{gd}}$          |  |     | 17   |      | nC            |
| <b>Drain-Source Diode Characteristics and Maximum Ratings</b>   |                          |  |     |      |      |               |
| Drain-Source Diode Forward Current  | $I_S^f$                  |  |     |      | 10   | A             |
| Drain-Source Diode Forward Voltage <sup>b</sup>   | $V_{\text{SD}}$          | $V_{\text{GS}} = 0\text{V}, I_S = 10\text{A}^g$  |     |      | 1.4  | V             |
| <b>Notes :</b>  |                          |  |     |      |      |               |
| a.Repetitive Rating : Pulse width limited by maximum junction temperature .   |                          |  |     |      |      |               |
| b.Pulse Test : Pulse Width $\leq 300\mu\text{s}$ , Duty Cycle $\leq 2\%$ .  |                          |  |     |      |      |               |
| c.Guaranteed by design, not subject to production testing.  |                          |  |     |      |      |               |
| d.Limited only by maximum temperature allowed .   |                          |  |     |      |      |               |
| e.Pulse width limited by safe operating area .  |                          |  |     |      |      |               |
| f.Full package $I_{\text{S(max)}} = 6\text{A}$ .  |                          |  |     |      |      |               |
| g.Full package $V_{\text{SD}}$ test condition $I_S = 6\text{A}$ .   |                          |  |     |      |      |               |
| h. $L = 15\text{mH}, I_{\text{AS}} = 5\text{A}, V_{\text{DD}} = 50\text{V}, R_G = 25\Omega$ , Starting $T_J = 25^\circ\text{C}$ |                          |  |     |      |      |               |



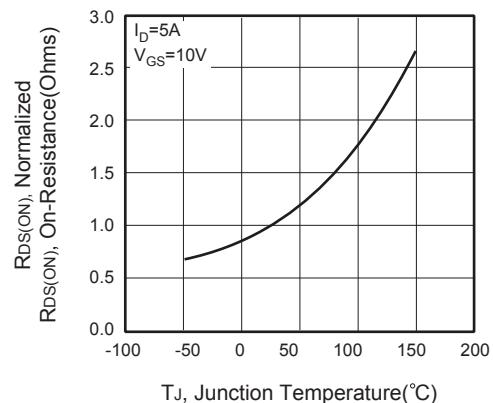
**Figure 1. Output Characteristics**



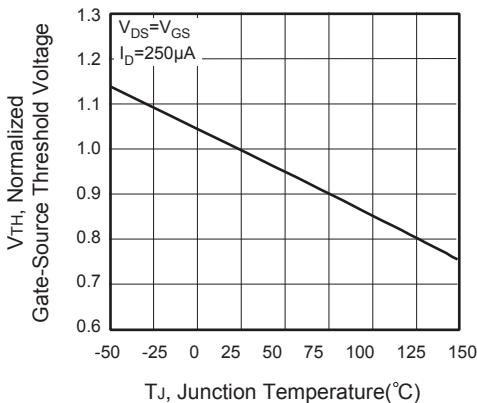
**Figure 2. Transfer Characteristics**



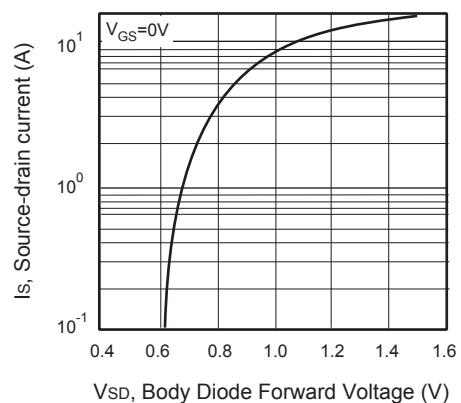
**Figure 3. Capacitance**



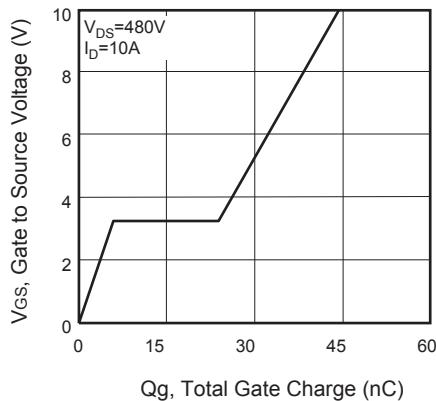
**Figure 4. On-Resistance Variation with Temperature**



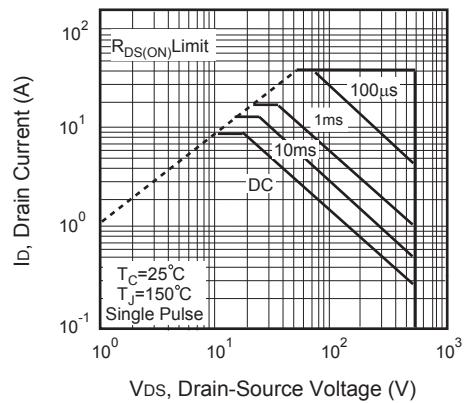
**Figure 5. Gate Threshold Variation with Temperature**



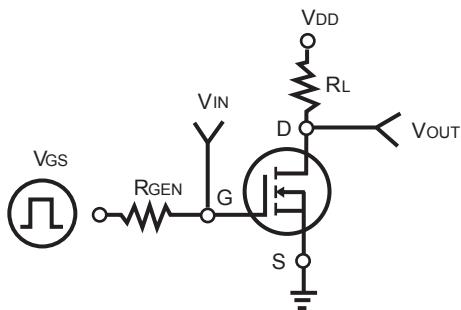
**Figure 6. Body Diode Forward Voltage Variation with Source Current**



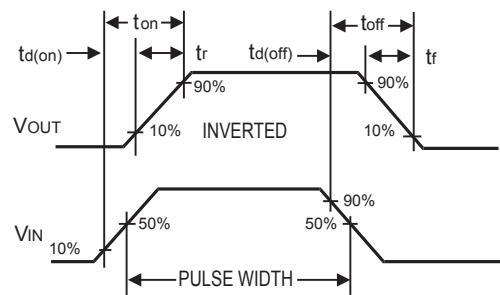
**Figure 7. Gate Charge**



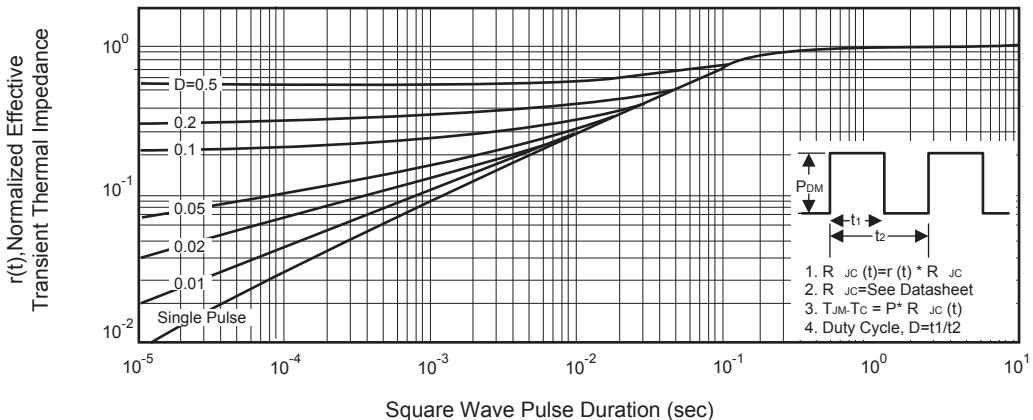
**Figure 8. Maximum Safe Operating Area**



**Figure 9. Switching Test Circuit**



**Figure 10. Switching Waveforms**



**Figure 11. Normalized Thermal Transient Impedance Curve**